

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hideomi Suzawa et al. Art Unit : 2812
Serial No. : 09/852,672 Examiner : Alexander G. Ghyka
Filed : May 11, 2001
Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

MAIL STOP RCE

Commissioner for Patents
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Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form.
Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: 4/7/05

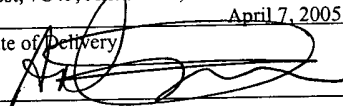
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-038001	Application No. 09/852,672
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hideomi Suzawa et al.	
		Filing Date May 11, 2001	Group Art Unit 2812

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2002-0028544	03/07/2002	Fujimoto et al.			07/30/2001
	AB	2003-0211664	11/13/2003	Fujimoto et al.			06/09/2003
	AC	2004-0169183	09/02/2004	Fujimoto et al.			03/05/2004
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	AE	6,707,068	03/16/2004	Fujimoto et al.			06/09/2003
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	AG						
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	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
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Other Documents (include Author, Title, Date, and Place of Publication)		
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